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IGBT

SGH20N60RUFD

Short Circuit Rated IGBT

General Description

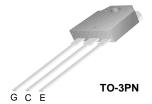
Fairchild's RUFD series of Insulated Gate Bipolar Transistors (IGBTs) provide low conduction and switching losses as well as short circuit ruggedness. The RUFD series is designed for applications such as motor control, uninterrupted power supplies (UPS) and general inverters where short circuit ruggedness is a required feature.

Features

- Short circuit rated 10us @ $T_C = 100$ °C, $V_{GE} = 15$ V
- · High speed switching
- Low saturation voltage : $V_{CE(sat)} = 2.2 \text{ V} @ I_C = 20 \text{A}$
- High input impedance
- CO-PAK, IGBT with FRD : $t_{rr} = 50$ ns (typ.)

Applications

AC & DC motor controls, general purpose inverters, robotics, and servo controls.





Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Description		SGH20N60RUFD	Units
V _{CES}	Collector-Emitter Voltage		600	V
V _{GES}	Gate-Emitter Voltage		± 20	V
	Collector Current	@ T _C = 25°C	32	А
IC	Collector Current	@ T _C = 100°C	20	А
I _{CM (1)}	Pulsed Collector Current		60	А
I _F	Diode Continuous Forward Current	@ T _C = 100°C	25	А
I _{FM}	Diode Maximum Forward Current		220	А
T _{SC}	Short Circuit Withstand Time	@ T _C = 100°C	10	us
P _D	Maximum Power Dissipation	@ T _C = 25°C	195	W
	Maximum Power Dissipation	@ T _C = 100°C	75	W
TJ	Operating Junction Temperature		-55 to +150	°C
T _{stg}	Storage Temperature Range		-55 to +150	°C
T _L	Maximum Lead Temp. for Soldering Purposes, 1/8" from Case for 5 Seconds		300	°C

Notes

(1) Repetitive rating : Pulse width limited by max. junction temperature

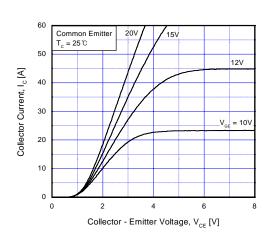
Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}(IGBT)$	Thermal Resistance, Junction-to-Case		0.64	°C/W
$R_{\theta JC}(DIODE)$	Thermal Resistance, Junction-to-Case		0.83	°C/W
R _{θJA} Thermal Resistance, Junction-to-Ambient			40	°C/W

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Chai	racteristics					
BV _{CES}	Collector-Emitter Breakdown Voltage	$V_{GE} = 0V, I_{C} = 250uA$	600			V
$\Delta B_{VCES}/$ ΔT_J	Temperature Coefficient of Breakdown Voltage	$V_{GE} = 0V, I_C = 1mA$		0.6		V/°C
I _{CES}	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0V$			250	uA
I _{GES}	G-E Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0V$			± 100	nA
On Char	acteristics					
V _{GE(th)}	G-E Threshold Voltage	$I_C = 20$ mA, $V_{CE} = V_{GE}$	5.0	6.0	8.5	V
*GE(th)	Collector to Emitter	$I_C = 20A$, $V_{GE} = 15V$		2.2	2.8	V
$V_{CE(sat)}$	Saturation Voltage	$I_C = 32A$, $V_{GE} = 15V$		2.5		V
	-	C - / GL				
	c Characteristics	T	1			
C _{ies}	Input Capacitance	$V_{CE} = 30V_{GE} = 0V_{GE}$		1323		pF
C _{oes}	Output Capacitance	f = 1MHz		254		pF_
C _{res}	Reverse Transfer Capacitance			47		pF
Switchir	ng Characteristics					
t _{d(on)}	Turn-On Delay Time			30		ns
t _r	Rise Time			49		ns
t _{d(off)}	Turn-Off Delay Time	$V_{CC} = 300 \text{ V}, I_{C} = 20\text{A},$		48	70	ns
t _f	Fall Time	$R_G = 10\Omega$, $V_{GE} = 15V$,		152	200	ns
E _{on}	Turn-On Switching Loss	Inductive Load, T _C = 25°C		524		uJ
E _{off}	Turn-Off Switching Loss			473		uJ
E _{ts}	Total Switching Loss			997	1400	uJ
t _{d(on)}	Turn-On Delay Time			30		ns
t _r	Rise Time			51		ns
t _{d(off)}	Turn-Off Delay Time	$V_{CC} = 300 \text{ V}, I_{C} = 20\text{A},$		52	75	ns
t _f	Fall Time	$R_G = 10\Omega, V_{GE} = 15V,$		311	400	ns
E _{on}	Turn-On Switching Loss	Inductive Load, T _C = 125°C		568		uJ
E _{off}	Turn-Off Switching Loss			1031		uJ
E _{ts}	Total Switching Loss	1		1599	2240	uJ
T _{sc}	Short Circuit Withstand Time	V _{CC} = 300 V, V _{GE} = 15V @ T _C = 100°C	10			us
Q _q	Total Gate Charge			55	80	nC
Q _{ge}	Gate-Emitter Charge	$V_{CE} = 300 \text{ V}, I_{C} = 20\text{A},$		10	15	nC
Q _{gc}	Gate-Collector Charge	V _{GE} = 15V		25	40	nC

Electrical Characteristics of DIODE $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Units
V	Diado Forward Voltago	I _F = 25A	$T_C = 25^{\circ}C$		1.4	1.7	V
V_{FM}	Diode Forward Voltage	I _F = 25A	T _C = 100°C		1.3		V
+	Diode Reverse Recovery Time Diode Peak Reverse Recovery I _F = 25A,		$T_C = 25^{\circ}C$		50	95	nc
^t rr			T _C = 100°C		105		ns
1		I _F = 25A,	$T_C = 25^{\circ}C$		4.5	10	Α
¹ rr	Current	di/dt = 200 A/us	T _C = 100°C		8.5		A
0	Diode Reverse Recovery Charge		$T_C = 25^{\circ}C$		112	375	nC
Q _{rr}			T _C = 100°C	-	420		





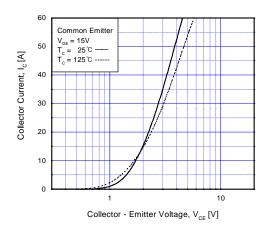


Fig 2. Typical Saturation Voltage Characteristics

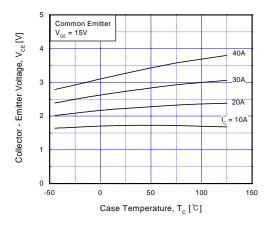


Fig 3. Saturation Voltage vs. Case
Temperature at Variant Current Level

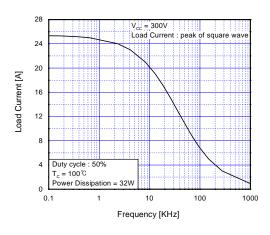


Fig 4. Load Current vs. Frequency

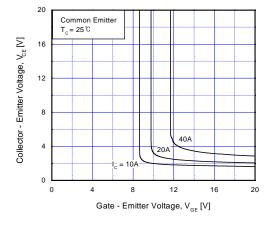


Fig 5. Saturation Voltage vs. V_{GE}

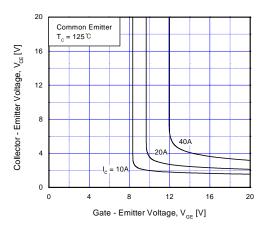


Fig 6. Saturation Voltage vs. V_{GE}

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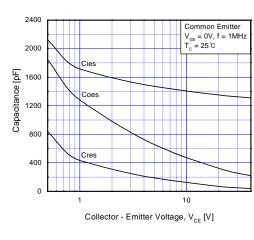
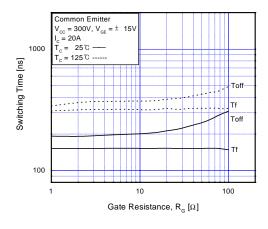


Fig 7. Capacitance Characteristics

Fig 8. Turn-On Characteristics vs.
Gate Resistance



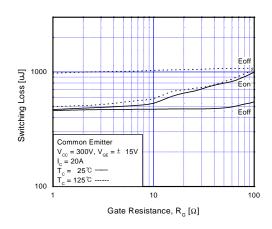
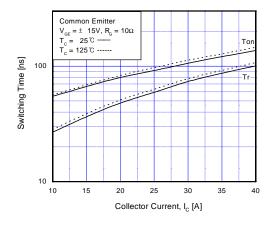


Fig 9. Turn-Off Characteristics vs.
Gate Resistance

Fig 10. Switching Loss vs. Gate Resistance



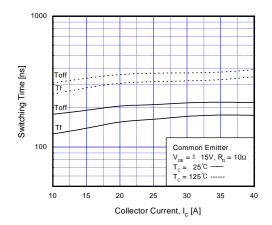
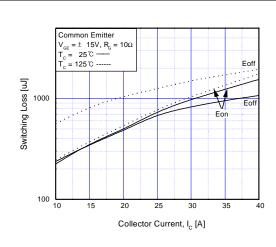


Fig 11. Turn-On Characteristics vs. Collector Current

Fig 12. Turn-Off Characteristics vs. Collector Current



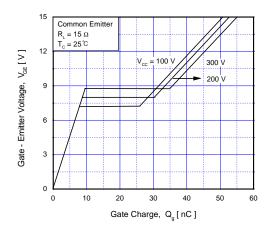
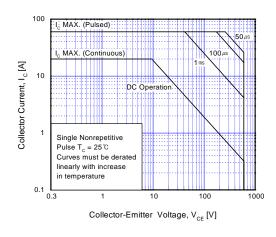


Fig 13. Switching Loss vs. Collector Current

Fig 14. Gate Charge Characteristics



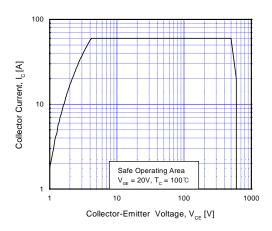


Fig 15. SOA Characteristics

Fig 16. Turn-Off SOA Characteristics

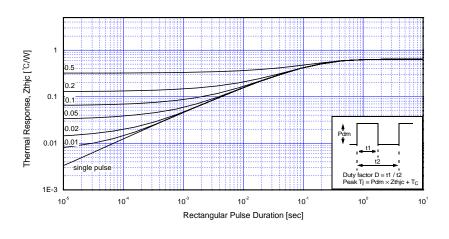
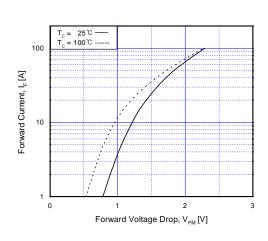


Fig 17. Transient Thermal Impedance of IGBT



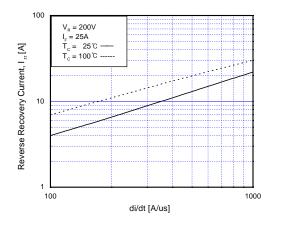
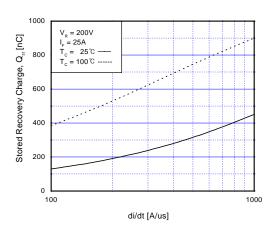


Fig 18. Forward Characteristics

Fig 19. Reverse Recovery Current



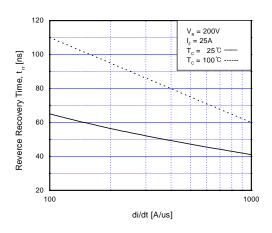
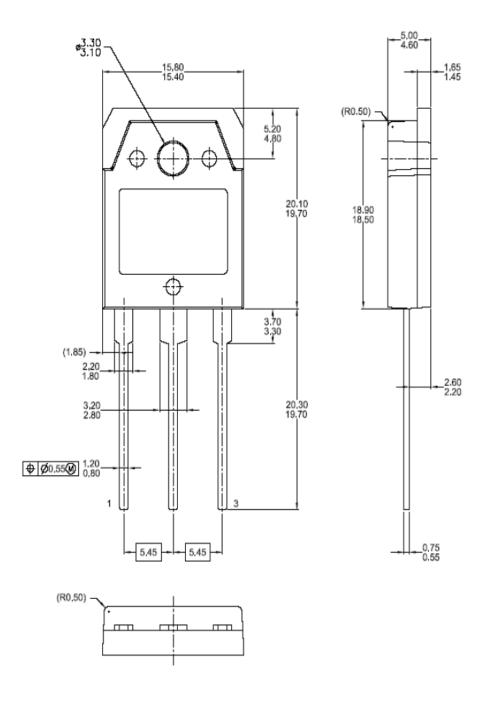


Fig 20. Stored Charge

Fig 21. Reverse Recovery Time



TO-3PN



Dimensions in Millimeters

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